

Notice of References Cited	Application/Control No. 10/799,758		Applicant(s)/Patent Under Reexamination FUNAKAWA ET AL.	
	Examiner MARCUS T. RILEY		Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,069,706 A	05-2000	Kajita et al.	358/1.15
*	B	US-6,538,764 B2	03-2003	Ueda, Shigeru	358/1.16
*	C	US-7,268,902 B2	09-2007	Hino, Yasuhiro	358/1.15
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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